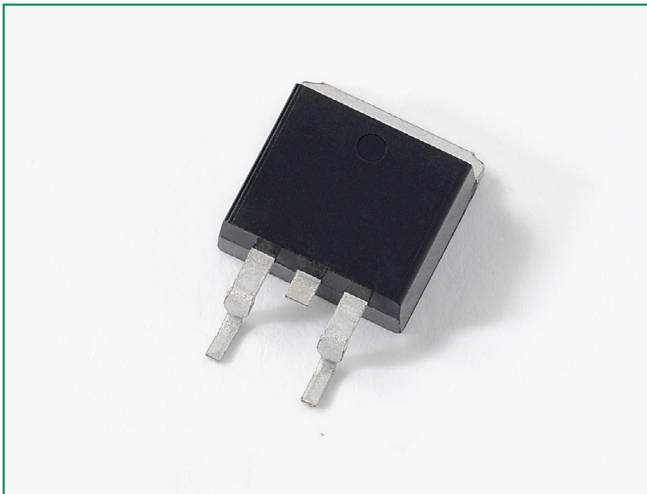




**THE DATASHEET OF  
NGD8201BNT4G**



# NGD8201B - 20 A, 400 V, N-Channel Ignition IGBT, DPAK



20 Amps, 400 Volts  
 $V_{CE(on)} \leq 1.8 V @$   
 $I_C = 10 A, V_{GE} \geq 4.5 V$

### Maximum Ratings ( $T_J = 25^\circ C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	$V_{CES}$	430	$V_{DC}$
Gate–Gate Voltage	$V_{CER}$	430	$V_{DC}$
Gate–Emitter Voltage	$V_{GE}$	18	$V_{DC}$
Collector Current–Continuous @ $T_C = 25^\circ C$ – Pulsed	$I_C$	15 50	$A_{DC}$ $A_{AC}$
ESD (Human Body Model) $R = 1500 \Omega, C = 100 pF$	ESD	8.0	kV
ESD (Machine Model) $R = 0 \Omega, C = 200 pF$	ESD	800	V
Total Power Dissipation @ $T_C = 25^\circ C$ Derate above $25^\circ C$	$P_D$	115 0.77	Watts $W/^\circ C$
Operating and Storage Temperature Range	$T_J, T_{stg}$	-55 to +175	$^\circ C$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

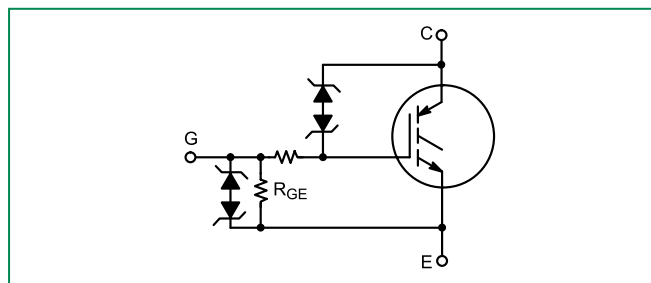
### Description

This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Over–Voltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

### Features

- Ideal for Coil–on–Plug and Driver–on–Coil Applications
- DPAK Package Offers Smaller Footprint for Increased Board Space
- Gate–Emitter ESD Protection
- Temperature Compensated Gate–Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- New Design Increases Unclamped Inductive Switching (UIS) Energy Per Area
- Low Threshold Voltage for Interfacing Power Loads to Logic or Microprocessor Devices
- Low Saturation Voltage
- High Pulsed Current Capability
- Emitter Ballasting for Short–Circuit Capability
- These are Pb–Free Devices

### Functional Diagram



### Additional Information



Datasheet



Resources



Samples

**Unclamped Collector–to–Emitter Avalanche Characteristics (-55°C ≤ T<sub>J</sub> ≤ 175°C)**

	Symbol	Value	Unit
<b>Single Pulse Collector–to–Emitter Avalanche Energy</b>			
V <sub>CC</sub> = 50 V, V <sub>GE</sub> = 5.0 V, P <sub>k</sub> I <sub>L</sub> = 22 A, R <sub>G</sub> = 1000 Ω, L = 1.8 mH, Starting T <sub>J</sub> = 25°C	E <sub>AS</sub>	435	mJ
V <sub>CC</sub> = 50 V, V <sub>GE</sub> = 5.0 V, P <sub>k</sub> I <sub>L</sub> = 17 A, R <sub>G</sub> = 1000 Ω, L = 3.0 mH, Starting T <sub>J</sub> = 25°C		433	
V <sub>CC</sub> = 50 V, V <sub>GE</sub> = 5.0 V, P <sub>k</sub> I <sub>L</sub> = 19 A, R <sub>G</sub> = 1000 Ω, L = 1.8 mH, Starting T <sub>J</sub> = 125°C		325	
<b>Reverse Avalanche Energy</b>			
V <sub>CC</sub> = 100 V, V <sub>GE</sub> = 20 V, P <sub>k</sub> I <sub>L</sub> = 25.8 A, L = 6.0 mH, Starting T <sub>J</sub> = 25°C	E <sub>AS (R)</sub>	2000	mJ

**Thermal Characteristics**

	Symbol	Value	Unit
Thermal Resistance, Junction to Case	R <sub>θJC</sub>	1.3	°C/W
Thermal Resistance, Junction to Ambient DPAK (Note 1)	R <sub>θJA</sub>	95	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	T <sub>L</sub>	275	°C

1. When surface mounted to an FR4 board using the minimum recommended pad size

Electrical Characteristics - OFF

Characteristic	Symbol	Test Conditions	Temperature	Min	Typ	Max	Unit
Collector–Emitter Clamp Voltage	$BV_{CES}$	$I_C = 2.0 \text{ mA}$	$T_J = -40^\circ\text{C to } 150^\circ\text{C}$	380	395	420	V
		$I_C = 10 \text{ mA}$	$T_J = -40^\circ\text{C to } 150^\circ\text{C}$	390	405	430	
Zero Gate Voltage Collector Current	$I_{CES}$	$V_{CE} = 15 \text{ V}$ $V_{GE} = 0 \text{ V}$	$T_J = 25^\circ\text{C}$	–	–	2.0	$\mu\text{A}_{DC}$
			$T_J = 150^\circ\text{C}$	–	1.5	5	
			$T_J = -40^\circ\text{C}$	–	10	30*	
Reverse Collector–Emitter Clamp Voltage	$BV_{CES(R)}$	$I_C = -75 \text{ mA}$	$T_J = 25^\circ\text{C}$	27	33	35	$V_{DC}$
			$T_J = 150^\circ\text{C}$	30	36	40	
			$T_J = -40^\circ\text{C}$	25	32	35	
Reverse Collector–Emitter Leakage Current	$I_{CES(R)}$	$V_{CE} = -24 \text{ V}$	$T_J = 25^\circ\text{C}$	–	0.7	1.0	mA
			$T_J = 150^\circ\text{C}$	–	12	25*	
			$T_J = -40^\circ\text{C}$	–	0.1	1.0	
Gate–Emitter Clamp Voltage	$BV_{GES}$	$I_G = 5.0 \text{ mA}$	$T_J = -40^\circ\text{C to } 150^\circ\text{C}$	11	13	15	$V_{DC}$
Gate–Emitter Leakage Current	$I_{GES}$	$V_{GE} = 10.0 \text{ V}$	$T_J = -40^\circ\text{C to } 150^\circ\text{C}$	384	640	700	$\mu\text{A}_{DC}$
Gate–Emitter Resistor (Note 3)	$R_{GE}$	–	$T_J = -40^\circ\text{C to } 150^\circ\text{C}$	10	16	26	k $\Omega$

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

\*Maximum Value of Characteristic across Temperature Range.

**Electrical Characteristics - ON (Note 3)**

Characteristic	Symbol	Test Conditions	Temperature	Min	Typ	Max	Unit
Gate Threshold Voltage	$V_{GE(th)}$	$I_C = 1.0 \text{ mA}$ , $V_{GE} = V_{CE}$	$T_J = 25^\circ\text{C}$	1.2	1.5	1.8	$V_{DC}$
			$T_J = 150^\circ\text{C}$	0.8	1.0	1.3	
			$T_J = -40^\circ\text{C}$	1.4	1.7	2.0*	
Threshold Temperature Coefficient (Negative)	-	-	-	-	3.4	-	mV/°C
Collector-to-Emitter On-Voltage	$V_{CE(on)}$	$I_C = 6.0 \text{ A}$ , $V_{GE} = 4.0 \text{ V}$	$T_J = 25^\circ\text{C}$	1.0	1.2	1.5	$V_{DC}$
			$T_J = 150^\circ\text{C}$	1.0	1.2	1.5	
			$T_J = -40^\circ\text{C}$	1.0	1.2	1.5*	
		$I_C = 8.0 \text{ A}$ , $V_{GE} = 4.0 \text{ V}$	$T_J = 25^\circ\text{C}$	1.2	1.4	1.6*	
			$T_J = 150^\circ\text{C}$	1.2	1.4	1.6	
			$T_J = -40^\circ\text{C}$	1.2	1.4	1.6*	
		$I_C = 10 \text{ A}$ , $V_{GE} = 4.0 \text{ V}$	$T_J = 25^\circ\text{C}$	1.3	1.5	1.8	
			$T_J = 150^\circ\text{C}$	1.3	1.5	1.9	
			$T_J = -40^\circ\text{C}$	1.3	1.6	1.8*	
		$I_C = 15 \text{ A}$ , $V_{GE} = 4.0 \text{ V}$	$T_J = 25^\circ\text{C}$	1.7	1.9	2.3	
			$T_J = 150^\circ\text{C}$	1.9	2.2	2.5*	
			$T_J = -40^\circ\text{C}$	1.5	1.9	2.3	
		$I_C = 10 \text{ A}$ , $V_{GE} = 4.5 \text{ V}$	$T_J = 25^\circ\text{C}$	1.3	1.5	1.8*	
			$T_J = 150^\circ\text{C}$	1.3	1.5	1.8*	
			$T_J = -40^\circ\text{C}$	1.3	1.5	1.8*	
$I_C = 6.5 \text{ A}$ , $V_{GE} = 3.7 \text{ V}$	$T_J = 25^\circ\text{C}$	-	-	1.65			
Forward Transconductance	gfs	$I_C = 6.0 \text{ A}$ , $V_{CE} = 5.0 \text{ V}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$	8.0	14	25	Mhos

\*Maximum Value of Characteristic across Temperature Range.

3. Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

**Dynamic Characteristics**

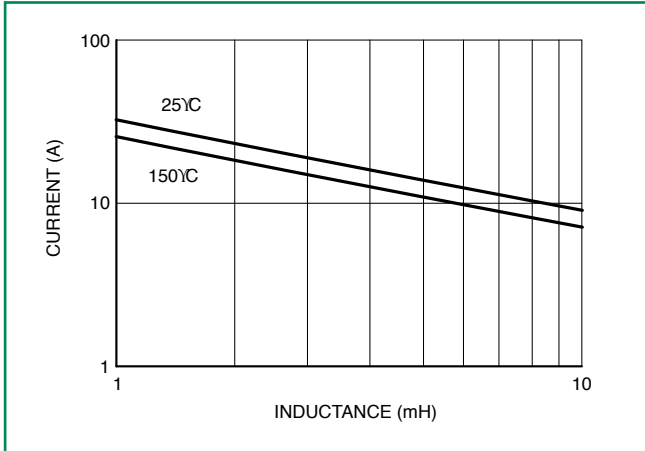
Characteristic	Symbol	Test Conditions	Temperature	Min	Typ	Max	Unit
Input Capacitance	$C_{ISS}$	$V_{CC} = 25\text{ V}$ $V_{GE} = 0\text{ V}$ $f = 1.0\text{ MHz}$	$T_J = -40^\circ\text{C}$ to $150^\circ\text{C}$	400	800	1000	pF
Output Capacitance	$C_{OSS}$			50	75	100	
Transfer Capacitance	$C_{RSS}$			4.0	7.0	10	

**Switching Characteristics**

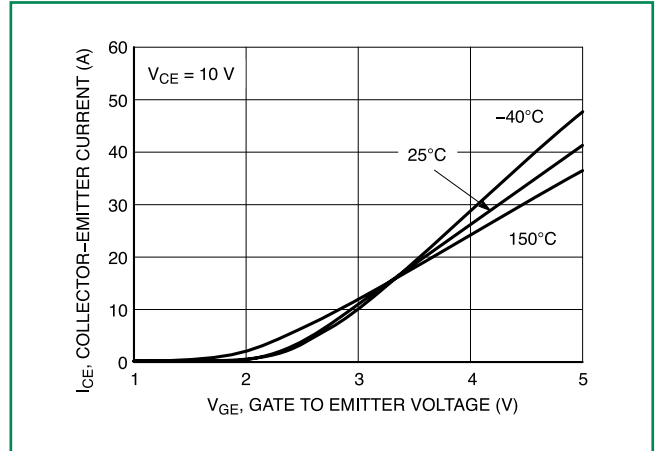
Characteristic	Symbol	Test Conditions	Temperature	Min	Typ	Max	Unit
Turn-Off Delay Time (Resistive)	$t_{d(off)}$	$V_{CC} = 300\text{ V}$ $I_C = 6.5\text{ A}$ $R_G = 1.0\text{ k}\Omega$ $R_L = 46\ \Omega$	$T_J = 25^\circ\text{C}$	–	4.0	10	μSec
Fall Time (Resistive)	$t_f$		$T_J = 25^\circ\text{C}$	–	9.0	15	
Turn-On Delay Time	$t_{d(on)}$	$V_{CC} = 10\text{ V}$ $I_C = 6.5\text{ A}$ $R_G = 1.0\text{ k}\Omega$ $R_L = 1.5\ \Omega$	$T_J = 25^\circ\text{C}$	–	0.7	4.0	
Rise Time	$t_r$		$T_J = 25^\circ\text{C}$	–	4.5	7.0	

**Typical Electrical Characteristics**

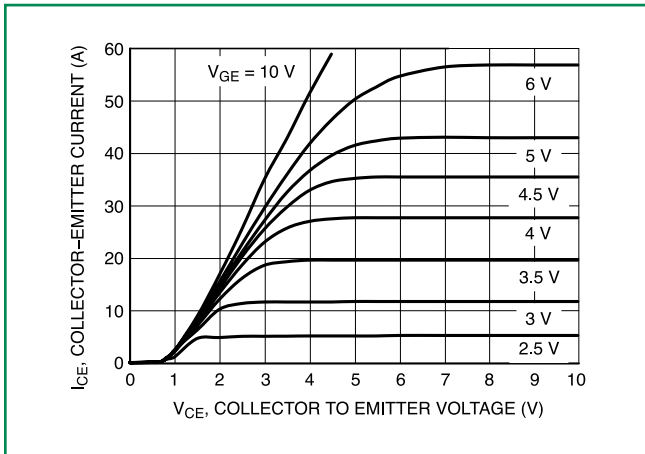
**Figure 1. Maximum Single Pulse Switch Off Current vs. Inductance**



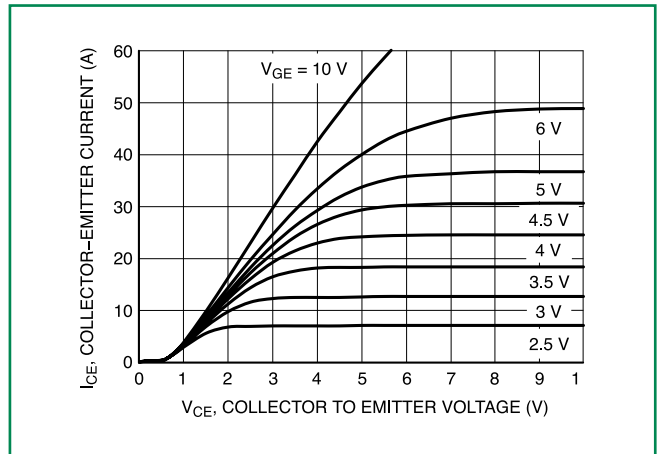
**Figure 2. Transfer Characteristics**



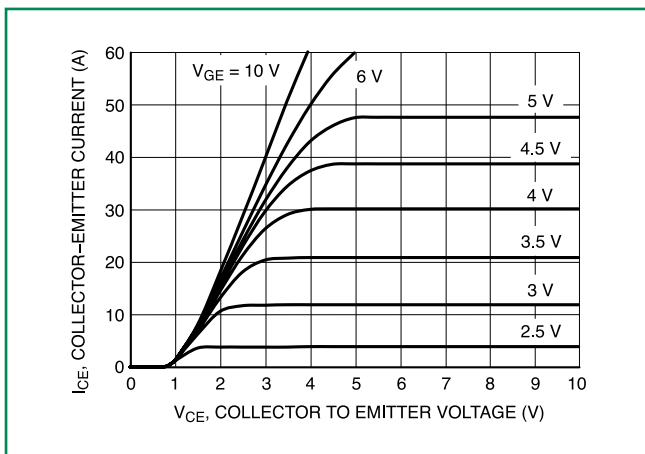
**Figure 3. Output Characteristics, T<sub>j</sub> = 25°C**



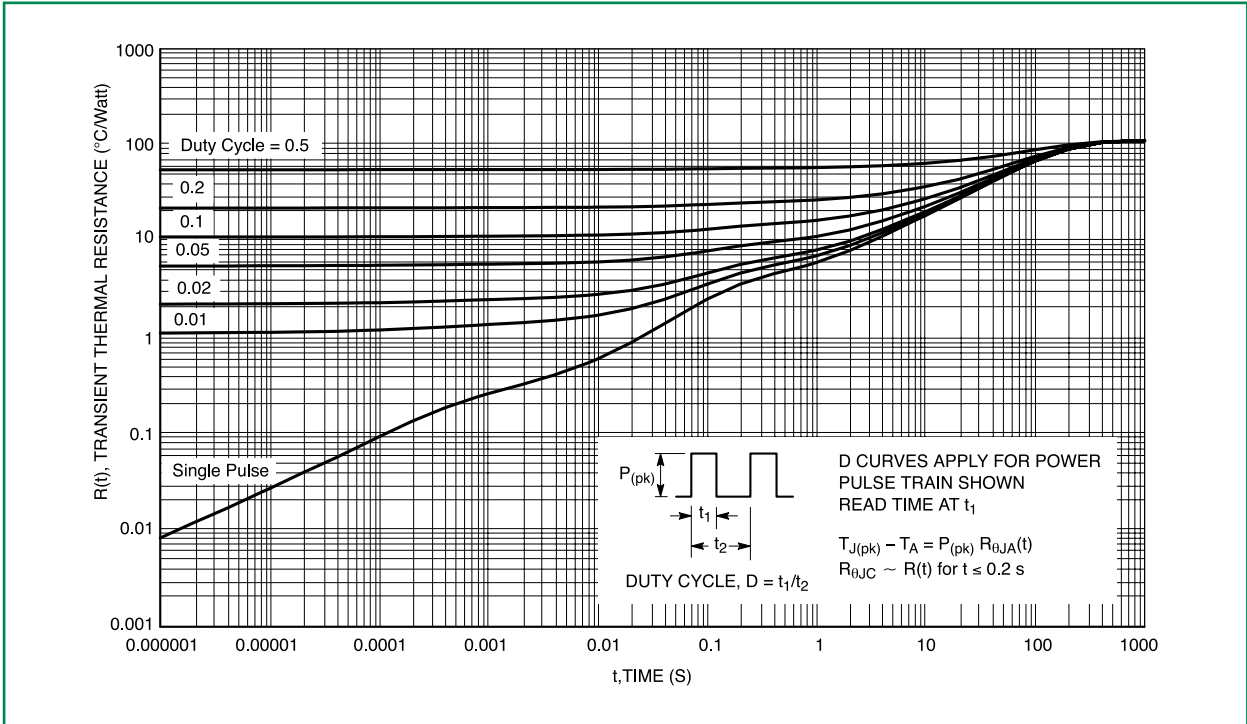
**Figure 4. On-Region Characteristics, T<sub>j</sub> = 150°C**



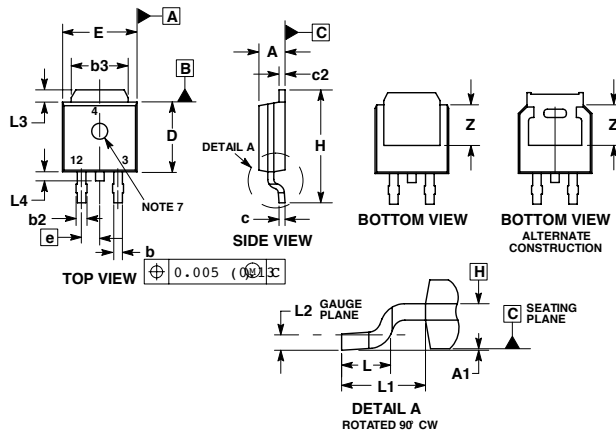
**Figure 5. On-Region Characteristics, T<sub>j</sub> = -40°C**



**Figure 6. Transient Thermal Resistance (Non-normalized Junction-to-Ambient mounted on minimum pad area)**



**Dimensions**

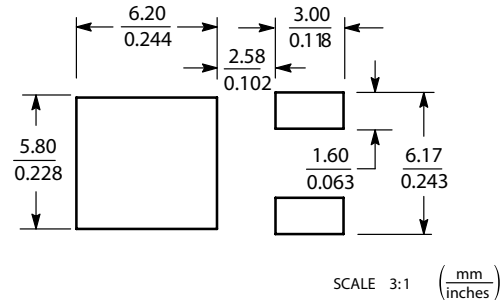


Dim	Inches		Millimeters	
	Min	Max	Min	Max
A	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
c	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
e	0.090 BSC		2.29 BSC	
H	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114 REF		2.90 REF	
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4	---	0.040	---	1.01
Z	0.155	---	3.93	---

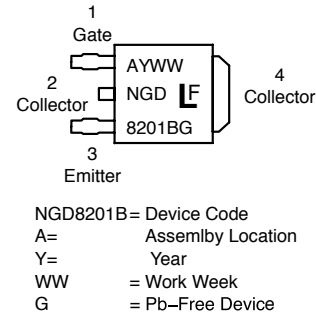
**NOTES:**

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: INCH.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- OPTIONAL MOLD FEATURE.

**Soldering Footprint**



**Part Marking System**



**ORDERING INFORMATION**

Device	Package	Shipping†
NGD8201BNT4G	DPAK (Pb-Free)	2,500 / Tape & Reel

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